

# SILICON POWER TRANSISTOR 2SA1741

# PNP SILICON EPITAXIAL TRANSISTOR FOR HIGH-SPEED SWITCHING

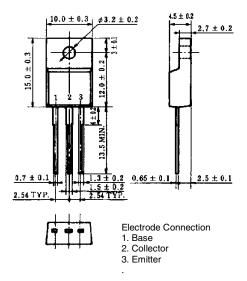
The 2SA1741 is a power transistor developed for high-speed switching and features a high hfe at low VCE(sat). This transistor is ideal for use as a driver in DC/DC converters and actuators.

In addition, a small resin-molded insulation type package contributes to high-density mounting and reduction of mounting cost.

#### **FEATURES**

- High hre and low  $V_{CE(sat)}$ : hre  $\geq$  100 ( $V_{CE}=-2$  V,  $I_{C}=-1$  A)  $V_{CE(sat)}\leq$  0.3 V ( $I_{C}=-3$  A,  $I_{B}=-0.15$  A)
- Full-mold package that does not require an insulating board or bushing when mounting.

## PACKAGE DRAWING (UNIT: mm)



#### ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

Parameter	Symbol	Ratings	Unit
Collector to base voltage	Vcво	-100	٧
Collector to emitter voltage	VCEO	-60	٧
Emitter to base voltage	VEBO	-7.0	V
Collector current (DC)	Ic(DC)	-5.0	Α
Collector current (pulse)	IC(pulse)*	-10	Α
Base current (DC)	I <sub>B(DC)</sub>	-2.5	Α
Total power dissipation	P⊤ (Tc = 25°C)	25	W
Total power dissipation	P⊤ (Ta = 25°C)	2.0	W
Junction temperature	Tj	150	°C
Storage temperature	T <sub>stg</sub>	-55 to +150	°C

<sup>\*</sup> PW  $\leq$  300  $\mu$ s, duty cycle  $\leq$  50%

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#### **ELECTRICAL CHARACTERISTICS (Ta = 25°C)**

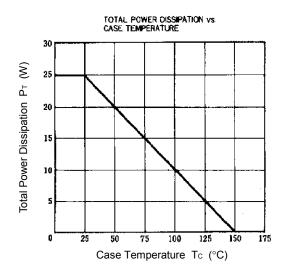
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector to emitter voltage	VCEO(SUS)	Ic = -3.0 A, Iв = -0.3 A, L = 1 mH	-60			V
Collector to emitter voltage	VCEX(SUS)	$I_C = -3.0 \text{ A}, I_{B1} = -I_{B2} = -0.3 \text{ A},$ $V_{BE(OFF)} = 1.5 \text{ V}, L = 180 \ \mu\text{H}, clamped$				V
Collector cutoff current	Ісво	Vcb = -60 V, IE = 0			-10	μΑ
Collector cutoff current	ICER	$V_{CE} = -60 \text{ V}, \text{ R}_{BE} = 50 \Omega, \text{ Ta} = 125^{\circ}\text{C}$			-1.0	mA
Collector cutoff current	ICEX1	$V_{CE} = -60 \text{ V}, V_{BE(OFF)} = 1.5 \text{ V}$			-10	μΑ
Collector cutoff current	ICEX2	$V_{CE} = -60 \text{ V}, V_{BE(OFF)} = 1.5 \text{ V},$ $Ta = 125 \text{ °C}$			-1.0	mA
Emitter cutoff current	ІЕВО	V <sub>EB</sub> = -5.0 V, I <sub>C</sub> = 0			-10	μΑ
DC current gain	hFE1*	Vce = -2.0 V, Ic = -0.5 A	100			
DC current gain	hFE2*	Vce = -2.0 V, Ic = -1.0 A	100		400	
DC current gain	h <sub>FE3</sub> *	$V_{CE} = -2.0 \text{ V, Ic} = -3.0 \text{ A}$	60			
Collector saturation voltage	V <sub>CE(sat)1</sub> *	Ic = -3.0  A, IB = -0.15  A			-0.3	V
Collector saturation voltage	VCE(sat)2*	Ic = -4.0  A, IB = -0.2  A			-0.5	V
Base saturation voltage	V <sub>BE(sat)1</sub> *	Ic = -3.0 A, I <sub>B</sub> = -0.15 A			-1.2	V
Base saturation voltage	V <sub>BE(sat)2</sub> *	Ic = -4.0  A, IB = -0.2  A			-1.5	V
Collector capacitance	Cob	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1.0 \text{ MHz}$		130		pF
Gain bandwidth product	f⊤	Vce = -10 V, Ic = -0.5 A		80		MHz
Turn-on time	ton	Ic = $-3.0$ A, R <sub>L</sub> = 17 $\Omega$ ,			0.3	μs
Storage time	tstg	$I_{B1} = -I_{B2} = -0.15 \text{ A}, \text{ Vcc } \cong -50 \text{ V}$ Refer to the test circuit.			1.5	μs
Fall time	tf	Tiere to the test circuit.			0.3	μs

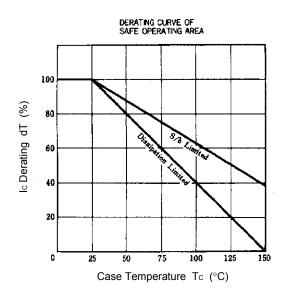
<sup>\*</sup> Pulse test PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2%

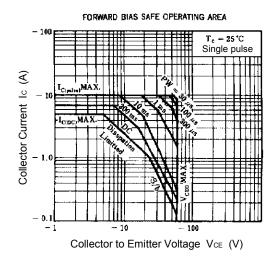
#### **hfe CLASSIFICATION**

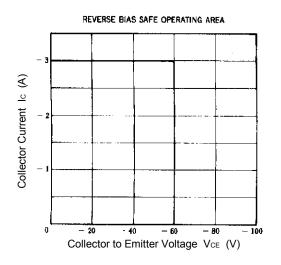
Marking	М	L	К
h <sub>FE2</sub>	100 to 200	150 to 300	200 to 400

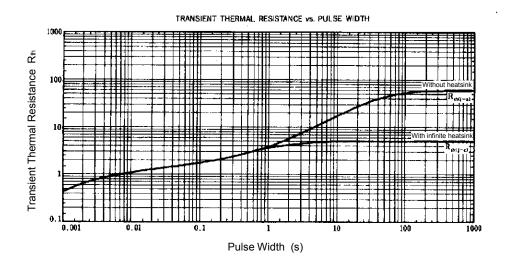
### TYPICAL CHARACTERISTICS (Ta = 25°C)

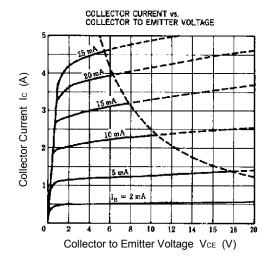


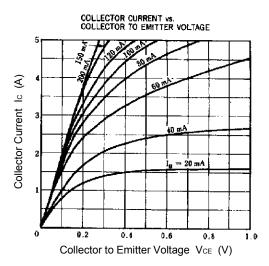






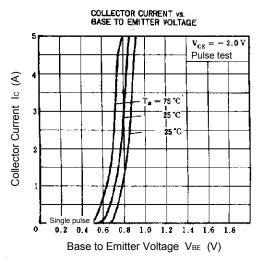




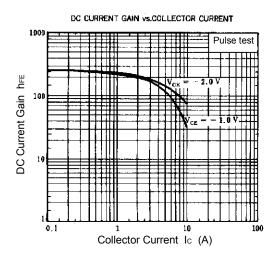


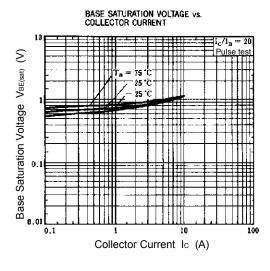
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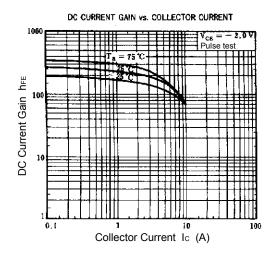


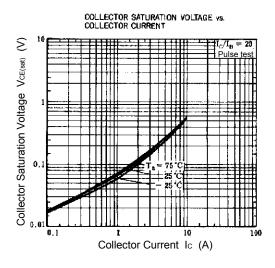


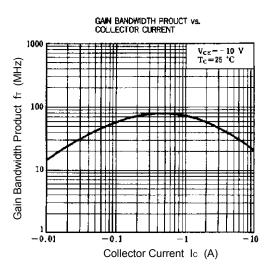


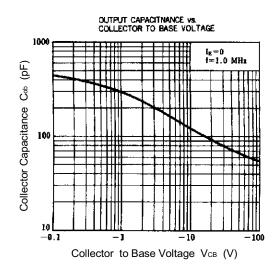


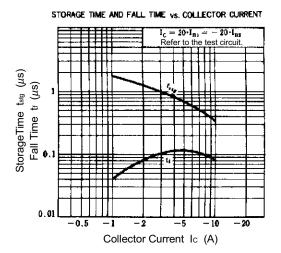




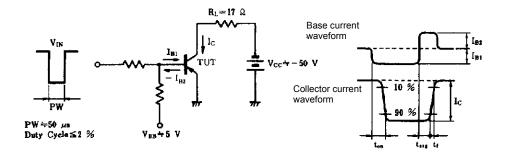








#### SWITCHING TIME (ton, tstg, tf) TEST CIRCUIT



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